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N-Channel 60 V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (mΩ)(Typ.)	I _D (A) ^a	Q _g (Typ.)		
60	3.8 at V _{GS} = 10 V	80	98 nC		

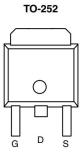
FEATURES

- 175 °C Junction Temperature
- DT-Trench Power MOSFET

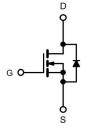


APPLICATIONS

- Notebook PC Core
- VRM/POL



Top View



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ABSOLUTE MAXIMUM RATINGS (T _A = 25 °C, unless otherwise noted)						
Parameter		Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	60	V		
Gate-Source Voltage		V _{GS}	± 20	V		
Continuous Drain Current (T ₁ = 175 °C)	T _C = 25 °C	L	80 ^{b, c}			
Continuous Brain Carrent (1) 170 O)	T _C = 70 °C	- I _D	70 ^{b, c}	A		
Pulsed Drain Current		I _{DM}	240			
Avalanche Current Pulse	L = 0.1 mH	I _{AS}	85			
Single Pulse Avalanche Energy	L = 0.1 IIIH	E _{AS}	250	mJ		
Continuous Source-Drain Diode Current	T _C = 25 °C	I _S	80 ^a	А		
Maximum Power Dissipation	T _C = 25 °C	P _D	180 ^{b, c}	W		
	T _C = 70 °C]	115 ^{b, c}			
Operating Junction and Storage Temperature Range		T _J , T _{stg}	- 55 to 175	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^b	t ≤ 10 s	R _{thJA}	11	15	°C/W	
Maximum Junction-to-Case	Steady State	R _{thJC}	0.75	1.0	C/VV	

Notes:
a. Based on T_C = 25 °C.
b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

Rev.B

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Parameter	Symbol	Test Conditions	Min .	Тур.	Max.	Unit
Static						
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	60			V
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	1		3.5	V
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 \text{ V}, V_{GS} = \pm 20 \text{ V}$			± 100	nA
Zana Cata Valtana Brain Comment	I _{DSS}	V _{DS} =60 V, V _{GS} = 0 V			1	
Zero Gate Voltage Drain Current		$V_{DS} = 60 \text{ V}, V_{GS} = 0 \text{ V}, T_{J} = 55 ^{\circ}\text{C}$			10	μA
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 \text{ V}, V_{GS} = 10 \text{ V}$	100			Α
Drain-Source On-State Resistance ^a	R _{DS(on)}	V _{GS} = 10 V, I _D = 10 A		3.8	4.5	mΩ
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 10 A		80		S
Dynamic ^b	<u>, </u>				<u>. </u>	
Input Capacitance	C _{iss}			6200		
Output Capacitance	C _{oss}	$V_{DS} = 30 \text{ V}, V_{GS} = 0 \text{ V}, f = 1 \text{ MHz}$		430		pF
Reverse Transfer Capacitance	C _{rss}			430		
Total Gate Charge	Q_g			98		nC
Gate-Source Charge	Q _{gs}	$V_{DS} = 30 \text{ V}, V_{GS} = 10 \text{ V}, I_D = 10 \text{ A}$		17		
Gate-Drain Charge	Q _{gd}			28		
Gate Resistance	R _g	f = 1 MHz		1.3		Ω
Turn-On Delay Time	t _{d(on)}			18		
Rise Time	t _r	$V_{DD} = 30 \text{ V}, R_{L} = 0.6 \Omega$		20		ns
Turn-Off Delay Time	t _{d(off)}	$I_D \cong 10 \text{ A, V}_{GEN} = 10 \text{ V, } R_g = 2.5 \Omega$		25		
Fall Time	t _f			10		
Drain-Source Body Diode Characteristics						
Continuous Source-Drain Diode Current	I _S	T _C = 25 °C			80	A
Pulse Diode Forward Current ^a	I _{SM}				240	
Body Diode Voltage	V _{SD}	I _S = 1 A		0.6	1	V
Body Diode Reverse Recovery Time	t _{rr}	L = 10 A di/dt = 100 A/up T = 25 °C		30		ns
Body Diode Reverse Recovery Charge	Q _{rr}	I _F = 10 A, di/dt = 100 A/μs, T _J = 25 °C		80		nC

Notes:

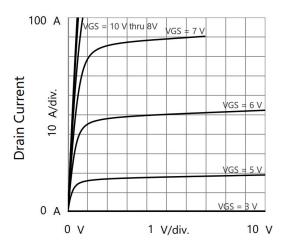
- a. Pulse test; pulse width $\leq 300~\mu s,$ duty cycle $\leq 2~\%.$
- b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

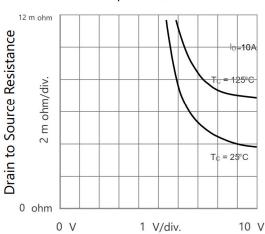


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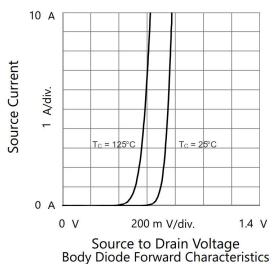
TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

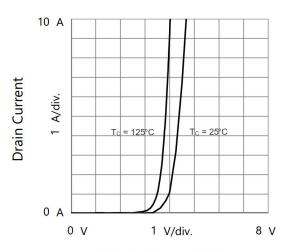


Drain to Source Voltage Output Characteristics

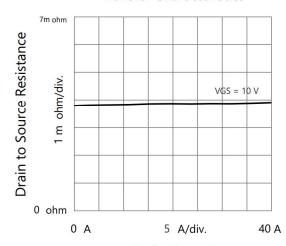


Gate to Source Voltage
Drain to Source Resistance vs. Gate to Source Voltage

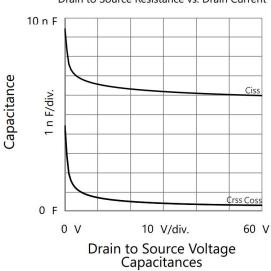




Gate to Source Voltage Transfer Characteristics

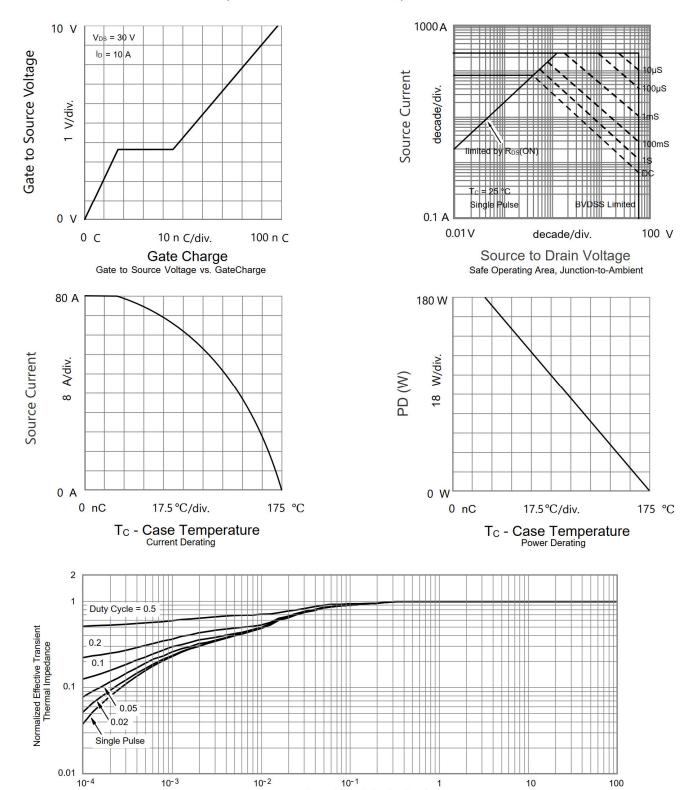


Drain Current
Drain to Source Resistance vs. Drain Current





TYPICAL CHARACTERISTICS (25 C, unless otherwise noted)



Normalized Thermal Transient Impedance, Junction-to-Case

Square Wave Pulse Duration (s)





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